## RF:

## Action Points at RAN5#93-e

| **Action ID** | **sWG** | **Action** | **Responsible** | **Relevant Tdoc** | **Deadline** | **Status** |
| --- | --- | --- | --- | --- | --- | --- |
| AP#93e.21 | RF | RF Provide text proposals for TRP-TRS MU Annex B of TR 38.834Updated descriptions are required for MU contributors classified as a) or b) | R&S, MVG, KS | R5-217600r3, R5-217756r1R5-220832R5-221175 | RAN5#94e | Open |

## Action Points at RAN5#92-e

| **Action ID** | **sWG** | **Action** | **Responsible** | **Relevant Tdoc** | **Deadline** | **Status** |
| --- | --- | --- | --- | --- | --- | --- |
| AP#92e.21 | RF | Provide a list of Tests impacted by applicability for different NS valuesUpdate TS38.522 to handle NS values applicability | CMCC, Qualcomm, Huawei, E/// | R5-215565, R5-215566 | RAN5#94e | Open |

## Action Points at RAN5#90-e

| **Action ID** | **sWG** | **Action** | **Responsible** | **Relevant Tdoc** | **Deadline** | **Status** |
| --- | --- | --- | --- | --- | --- | --- |
| AP#90e.23 | RF | Propose FR2 test procedure update to ensure UE transmit at FR2 UL CA status for UL CA FR2 test casesFR2\_PCC\_SCC\_Prio | Qualcomm, Oppo, VzW, E///, Anritsu, Apple, Huawei, R&S | R5-211227R5-212812R5-212840R5-213347/8R5-212919R5-212963R5-213092R5-213323R5-213324R5-215632R5-217652R5-217716R5-217717R5-221349R5-221348R5-221347R5-220889R5-221250R5-221346 | RAN5#94e | Open |

## Action Points at RAN5#89-e

| **Action ID** | **sWG** | **Action** | **Responsible** | **Relevant Tdoc** | **Deadline** | **Status** |
| --- | --- | --- | --- | --- | --- | --- |
| AP#89e.23 | RF | Provide input on acceptable clipping frequency due to fading and/or acceptable fading crest factor margin for FR2 Demod performance and CSI test cases Provide input on the impact to TxEVM (and consequently SNR) for higher probabability of saturation of faded signalFR2\_Demod\_MU | Qualcomm, Anritsu, Keysight, E///, R&S | R5-206168, R5-205702R5-211083R5-212961R5-213335R5-212030/31/32R5-215661, R5-214204, R5-214852, R5-214202/3R5-217653R5-221163R5-221164R5-221249 | RAN5#94e | Open |
| AP#89e.24 | RF | On/Off time mask MU/ requirement relaxation open itemsa) Achievable power window PW for FR2 relative power control.b) Wherther there will be a degradation of TE noise floor if the maximum UE power can be as high as 22.4 + 2\*PW in the test.c) What is the maximum allowed UE ON power which will not degrade the current specified TE noise floor for OFF power measurement. Assess if this ON power is high enough to identify failing transient periods as shown in section 2.6.Tx\_On\_Off\_MU | KS, R&S, Anritsu, E///, Huawei, OPPO. | R5-205991r2R5-211105R5-211268R5-212626R5-212627R5-212628R5-213312R5-215325R5-215324R5-215480R5-217416R5-217417R5-217418R5-217556R5-220885R5-221269R5-220886R5-220884R5-221270 | RAN5#94e | Open |

## Action Points at RAN5#87-e

| **Action ID** | **sWG** | **Action** | **Responsible** | **Relevant Tdoc** | **Deadline** | **Status** |
| --- | --- | --- | --- | --- | --- | --- |
| AP#87e.21 | RF | Review the existing test point analysis of NR (FR1, FR2) RF tests for optimizationRF\_TP\_Optimization | DCM, Ericsson, Huawei, Qualcomm, Oppo, DISH, China Unicom, TMO, CAICT, CMCC, Sporton | R5-201818R5-202375R5-204136 | RAN5#94e | Open |